

CLAIMS:

1. A voltage divider arrangement comprising a reference terminal (1), an input terminal (2) for receiving an input signal with respect to said reference terminal (1), an output terminal (3) for supplying an output signal with respect to said reference terminal (1), and a resistor arrangement (20) arranged on a substrate (50) and coupled between said input
5 terminal (2) and said reference terminal (1), wherein a distributed compensation capacitance structure (10) for compensating the influence of a distributed parasitic capacitance is arranged between said resistor arrangement (20) and said substrate (50).
2. A voltage divider arrangement according to claim 1, wherein said resistor
10 arrangement (20) has a meandering shape.
3. A voltage divider arrangement according to claim 2, wherein said resistor arrangement (20) is made of poly-silicon.
- 15 4. A voltage divider arrangement according to any one of the preceding claims, wherein said distributed compensation capacitance structure (10) comprises a conductor layer of a predetermined shape.
5. A voltage divider arrangement according to claim 4, wherein said
20 predetermined shape is a triangular shape.
6. A voltage divider arrangement according to claim 4 or 5, wherein the width of said conductor layer in the horizontal direction is selected according to the following equation:

$$25 \quad D_k = \frac{DR}{1 + \frac{k}{M+1-k} \cdot \frac{CCMP_{sq}}{CP_{sq}}},$$

wherein CP_{sq} denotes the parasitic capacitance per unit area of resistor, DR denotes the length of said resistor arrangement (20), k denotes an index of a segment of said transistor

arrangement (20); M denotes the total number of segments of said transistor arrangement (20), $CCMP_{sq}$ denotes the distributed compensation capacitance per unit area of resistor and D_k denotes said width of said conductor layer.

- 5 7. A voltage divider arrangement according to any one of the preceding claims, wherein said distributed compensation capacitance structure (10) is separated from said resistor arrangement (20) and said substrate (50) by respective insulation layers (30, 40).